

<b>Notice of References Cited</b>	Application/Control No. 09/731,624	Applicant(s)/Patent Under Reexamination FRENCH ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,182,275 B1	01-2001	Beelitz et al.	717/175
	B	US-6,477,642 B1	11-2002	Lupo, Van Anthony	713/2
	C	US-6,457,122 B1	09-2002	Ramezani, Mehran	713/1
	D	US-5,737,610	04-1998	Sandig et al.	717/167
	E	US-6,658,486 B2	12-2003	Buzbee et al.	719/318
	F	US-5,802,365 A	09-1998	Kathail et al.	719/321
	G	US-6,564,252 B1	05-2003	Hickman et al.	709/214
	H	US-6,115,741 A	09-2000	Domenikos et al.	709/217
	I	US-6,066,182 A	05-2000	Wilde et al.	717/175
	J	US-6,662,198 B2	12-2003	Satyanarayanan et al.	707/204
	K	US-6,219,742 B1	04-2001	Stanley, Paul C.	710/260
	L	US-5,905,872 A	05-1999	DeSimone et al.	709/245
	M	US-6,584,499 B1	06-2003	Jantz et al.	709/220

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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